

# **FEATURES**

- Miniature 62-pin cermanic package
- 12-Bit resolution, 50kHz throughput
- Full-scale input range from 50mV to 10V
- Three-state outputs
- 16 S.E. or 8 differential input channels
- Auto-sequencing channel addressing
- MIL-STD-883 versions
- No missing codes
- Available in SMT or DIP packages

#### **GENERAL DESCRIPTION**

Using thin and thick-film hybrid technology, DATEL offers complete low-cost data acquisition systems with superior performance and reliability.

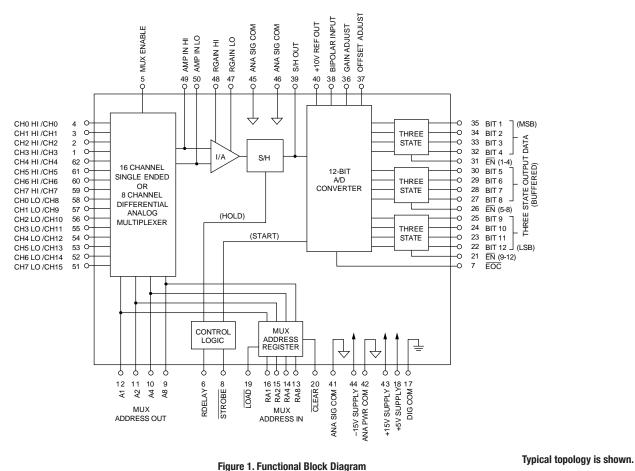
The HDAS-8 (with 8 differential input channels) and the HDAS-16 (with 16 single-ended input channels) are complete, high-performance, 12-bit data acquisition systems in 62-pin SMT or DIP packages. Each HDAS may be expanded up to 32 single-ended or 16 differential channels by adding externalmultiplexers.

Internal channel address sequencing is automatic after each conversion, or the user may supply external channel addresses.



#### **Internal HDAS circuitry includes:**

- Analog input multiplexer (16 S.E. or 8 diff.)
- Resistor-programmable instrumentation amplifier
- Sample-and-hold circuit complete with MOS hold capacitor
- 10 Volt buffered reference
- 12-bit A/D converter with three-state outputs and control logic





# HDAS-16, HDAS-8

12-Bit, 50kHz, Complete Data Acquisition Systems

ABSO	LUTE MAXIMUI	M BATINGS		
PARAMETERS	MIN.	TYP.	MAX.	UNITS
+15V Supply (pin 43)	-0.5	_	+18	Volts
–15V Supply (pin 44)	+0.5	_	-18	Volts
+5V Supply (pin 18)	-0.5	_	+7	Volts
Analog Inputs ①	-35	_	+35	Volts
Digital Inputs	-0.5	_	+7	Volts
Thermal Resistances:				
Junction-Case		_	15	°C/Watt
Case-Ambient		_	15	°C/Watt
Junction-Ambient		_	30	°C/Watt
Lead Temp. (10 seconds)		_	300	°C

# **FUNCTIONAL SPECIFICATIONS**

(The following specifications apply over the operating temperature range and power supply range unless otherwise indicated.)

0	_	1	
0	_		
_		+10	Volts
	—	+50	mV
-10	-	+10	Volts
-50	-	+50	mV
G	ain = 1 + (2)	20kΩ/RGAII	N)
_	_	±0.1	%
10 <sup>8</sup>	1012	_	Ohms
_	—	±250	pА
	Doubles e	very 10°C	
_	-	±1	nA
	Doubles e	very 10°C	
_		2	kΩ
_	±30		pА
—		—	nA
_	±100		pА
_	100	—	pF
—	50	—	pF
—	5	—	pF
_	-	±2	mV
(±3	pm/°C x Ga	ain) ±20ppi	m/°C
_	[ _	±100	mV
(±3	pm/°C x Ga	ain) ±20ppi	m/°C
±10	_	_	Volts
70	82	—	dB
_	150	200	μVrms
_	_	-80	dB
		l	l
12	_	_	Bits
	1	1	L
_	_	±1	LSB
_	<u> </u>	±1	LSB
	50 6 	$\begin{array}{c c c c c c c c c c c c c c c c c c c $	$\begin{array}{c c c c c c c c c c c c c c c c c c c $

-55 to +125°C			±1	LSB
			<u>⊥</u> 1	LOD
Differential Nonlinearity 0 to +70°C			±1	LSB
-40 to +100°C			±1	LSB
-55 to +125°C			±1	LSB
No Missing Codes	Over the	onerating	temperatur	-
				-
PERFORMANCE (CONT.)	MIN.	TYP.	MAX.	UNITS
Unipolar Zero Error				
+25°C ③		—	±0.1	%FSR
-40 to +100°C		—	±0.25 %	FSR
-55 to +125°C		—	±0.3	%FSR
Bipolar Zero Error				
+25°C ③		—	±0.1	%FSR
-40 to +100°C	—	—	±0.25 %	FSR
–55 to +125°C			±0.3	%FSR
Bipolar Offset Error				
+25°C ③			±0.1	%FSR
-40 to +100°C			±0.25 %	FSR
–55 to +125°C			±0.3	%FSR
Gain Error				
+25°C ③			±0.2	%
-40 to +100°C	—	—	±0.3 %	FSR
–55 to +125°C	_	—	±0.3	%
DYNAMIC CHARACTERISTICS				
Acquisition Time, Gain = 1				
+25°C		9	10	μs
-40 to +100°C		_	15	μs
–55 to +125°C			15	μs
Aperture Delay Time		_	500	ns
Aperture Uncertainty			1	ns
· · ·				
S/H Droop Rate			±1	µV/µs
Feedthrough	-	—	±0.01	%
A/D Conversion Time				
+25°C		6	8	μs
-40 to +100°C			10	μs
-55 to +125°C		—	10	μs
Throughput Rate				
+25°C	50	66		kHz
-40 to +100°C	33			kHz
–55 to +125°C	33	—	—	kHz
DIGITAL INPUTS				
Logic Levels				
(Pins 8, 13–16, 19–21, 26, 31)				
Logic 1	+2.0		+5.5	Volts
Logic 0	0		+0.8	Volts
(Pin 5)				
Logic 1	+4.0		+5.5	Volts
Logic 0	0	—	+0.8	Volts
Logic Loading				
(Pins 5, 8, 13–16, 19–21, 26, 31)				
Logic 1			±10	μA
Logic 0			±10	μA
Multiplexer Address Set-upTime	20			ns
ENABLE to Data Valid Delay		20	30	ns
STROBE ®	40	_		n
		I	1	



OUTDUTE

# HDAS-16, HDAS-8

12-Bit, 50kHz, Complete Data Acquisition Systems

OUTPUTS				
Logic Levels (Output Data)				
Logic 1	+2.4	—	—	Volts
Logic 1 (pin 7)	+2.5	—	—	Volts
Logic 0	—	—	+0.4	Volts
(Pins 9, 10, 11, and 12)				
Logic 1	+2.5	—	—	Volts
Logic 0	—	—	+0.4	Volts
Logic Loading				
Logic 1		—	-400	μA
Logic 0	—	—	+4	mA
OUTPUTS (CONT.)				
Internal Reference:				
Voltage, +25°C	+9.99	+10.00	+10.01	Volts
Drift		_	±20	ppm/°C
External Current		_	1	mA
Output Data Coding	Straight bin	ary (unipolar)	or offset bin	ary (bipolar)
POWER REQUIREMENTS	MIN.	TYP.	MAX.	UNITS
Power Supply Ranges				
+15V Supply	+14.25	+15.0	+15.75	Volts
–15V Supply	-14.25	-15.0	-15.75	Volts
+5V Supply	+4.75	+5.0	+5.25	Volts
Power Supply Currents				
+15V Supply			+33	mA
-15V Supply		_	-30	mA
+5V Suppy	—	—	+15	mA
Power Dissipation	_	_	1.25	Watts
PHYSICAL/ENVIRONMENTAL				
Operating Temp. Range, Case				
MC Models	0	_	+70	°C
ME Models	-40	—	+100	°C
MM/883 Models	-55	_	+125	°C
Storage Temperature Range	-65	—	+150	°C
Weight		4	00 7	->
· ·	1	.4 ounces	39.7 grams	s)
Package Type	1		manic DIP	5)

Footnotes:

 $\odot$  Analog inputs will withstand  $\pm 35{\rm V}$  with power on. If the power is off, the maximum safe input (no damage) is  $\pm 20{\rm V}.$ 

② The gain equation error is guaranteed before external trimming and applies at gains less than 50. This error increases at gains over 50.

Adjustable to zero.

④ STROBE pulse width must be less than EOC period to achieve maximum throughput rate.

PIN NO.		HDAS-16	HDAS-8
1	CH3 IN		CH3 HIGH IN
2	CH2 IN		CH2 HIGH IN
3	CH1 IN		CH1 HIGH IN
4	CH0 IN		CH0 HIGH IN
5	MUX ENABLE		*
6	RDELAY		*
7	EOC		*
8	STROBE		*
9	A8	MULTIPLEXER	*
10	A4	ADDRESS	*
11	A2	OUT	*
12	A1		*
13	RA8	MULTIPLEXER	*
14	RA4	ADDRESS	*
15	RA2	IN	*
16	RA1		*

PIN NO.	HDAS-16	HDAS-8
17	DIGITAL COMMON	*
18	+5V SUPPLY	*
10	LOAD	*
20	CLEAR	*
21	ENABLE (Bits 9–12)	*
22	BIT 12 (LSB)	*
23	BIT 11	*
24	BIT 10	*
24	BIT 9	*
20	ENABLE (Bits 5–8)	*
20	BIT 8	*
28	BIT 7	*
20	BIT 6	*
30	BIT 5	*
30	ENABLE (Bits 1–4)	*
31	BIT 4	*
-		*
33	BIT 3	*
34	BIT 2	*
35	BIT 1 (MSB)	*
36	GAIN ADJUST	*
37	OFFSET ADJUST	*
38	BIPOLAR INPUT	*
39	SAMPLE/HOLD OUT	*
40	+10V REFERENCE OUT	*
41	ANALOG SIGNAL COMMON	*
42	ANALOG POWER COMMON	*
43	+15V SUPPLY	*
44	-15V SUPPLY	
45	ANALOG SIGNAL COMMON	*
46	ANALOG SIGNAL COMMON	*
47	RGAIN LOW	*
48	RGAIN HIGH	*
49	AMP. IN HIGH	*
50	AMP. IN LOW	*
51	CH15 IN	CH7 LOW IN
52	CH14 IN	CH6 LOW IN
53	CH13 IN	CH5 LOW IN
54	CH12 IN	CH4 LOW IN
55	CH11 IN	CH3 LOW IN
56	CH10 IN	CH2 LOW IN
57	CH9 IN	CH1 LOW IN
58	CH8 IN	CH0 LOW IN
59	CH7 IN	CH7 HIGH IN
60	CH6 IN	CH6 HIGH IN
61	CH5 IN	CH5 HIGH IN
62	CH4 IN	CH4 HIGH IN

\*Same as HDAS-16

Caution: Pins 49 and 50 do not have overvoltage protection; therefore, protected multiplexers, such as MPS's MX-1606 and MX-808 are recommended. See the General Operation description.

# **TECHNICAL NOTES**

- 1. Input channels are protected to 20 Volts beyond the powersupplies. All digital output pins have one second short-circuit protection.
- To retain high system throughput rates while digitizing low-level signals, apply external high-gain amplifiers foreach channel. MPS's AM-551 is suggested for such amplifier-per-channel applications.
- 3. The HDAS devices have self-starting circuits for free-running sequential operation. If, however, in a power-upcondition the supply voltage slew rate is less than 3V per microsecond, the free running state might not be initialized. Apply a negative pulse to the STROBE, to eliminate this condition.
- 4. For unipolar operation, connect BIPOLAR INPUT (pin 38) to S/H OUT (pin 39). For bipolar operation, connect BIPOLAR INPUT (pin 38) to +10V REFERENCE OUT (pin 40).
- 5. RDELAY may be a standard value 5% carbon composition or film-type resistor.

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### **TECHNICAL NOTES continued**

6. RGAIN must be very accurate with low temperature coefficients. If necessary, fabricate the gain resistor from a precision metal-film type in series with a low value trim resistor or potentiometer. The total resistor temperature coefficient must be no greater than ±10ppm/°C.

#### **Table 1. Description of Pin Functions**

FUNCTION	LOGIC STATE	DESCRIPTION		
DIGITAL INPUTS				
STROBE	1 to 0	Initiates acquisition and conversion of analog signal		
LOAD	0	Random address mode initiated on falling edge of STROBE		
	1	Sequential address mode		
CLEAR	0	Allows next STROBE pulse to reset MULTIPLEXER ADDRESS to CHO overrid ing LOAD COMMAND		
MUX ENABLE	0	Disables internal multiplexer		
	1	Enables internal multiplexer		
MUX ADDRESS IN		Selects channel for random address mode 8, 4, 2, 1 natural binary coding		
DIGITAL OUTPUTS				
EOC (STATUS)	0	Conversion complete		
	1	Conversion in process		
ENABLE (1-4)	0	Enables three-state outputs bits 1-4		
	1	Disables three-state outputs bits 1-4		
ENABLE (5-8)	0	Enables three-state outputs bits 5-8		
	1	Disables three-state outputs bits 5-8		
ENABLE (9–12)	0	Enables three-state outputs bits 9-12		
	1	Disables three-state outputs bits 9-12		
MUX ADDRESS OUT		Output of multiplexer address register 8, 4, 2, 1 natural binary coding		
ANALOG INPUTS		DESCRIPTION		
CHANNEL INPUTS	Limit voltage to	b ±20V beyond power supplies		
BIPOLAR INPUT		peration, connect to pin 39 (S/H OUT). For on, connect to in 40 (+10V OUT)		
amp. In Low Amp. In High		direct inputs to the instrumentation tternal channel expansion beyond 16SE s.		
ANALOG OUTPUTS				
S/H OUT	Sample/hold o	utput		
+10V REFERENCE OUT	Buffered +10V	reference output		
ADJUSTMENT PINS				
ANALOG SIGNAL COMMON	Low level anal	og signal return		
GAIN ADJUSTMENT	External gain a	djustment. See calibration instructions.		
OFFSET ADJUSTMENT	External offset	adjustment. See calibration instructions.		
RGAIN	Optional gain s when left open	election point. Factory adjusted for $G = 1$		
RDELAY	to +5V. Factory	sition time adjustment when connected adjusted for 9µs. Must be connected to actly or through a resistor.		

- ANALOG SIGNAL COMMON, POWER COMMON and DIGITAL COMMON are connected internally. For optimal performance, tie all ground pins (17, 41, 42, 45, 46) directly to a large analog ground plane beneath the package.
- 8. For HDAS-16, tie pin 50 to a "signal source common" if possible. Otherwise tie pin 50 to pin 41 (ANA SIG COM).

	Table 2. Calibration Table	
UNIPOLAR RANGE	ADJUST	INPUT VOLTAGE
0 to +5V	ZERO GAIN	+0.6mV +4.9982V
0 to +10V	ZERO GAIN	+1.2mV +9.9963V
BIPOLAR RANGE		
±2.5V	OFFSET GAIN	-2.4994V +2.4982V
±5V	OFFSET GAIN	-4.9988V +4.9963V
±10V	OFFSET GAIN	-9.9976V +9.9927V

#### **Calibration Procedures**

- Offset and gain adjustments are made by connecting two 20k trim potentiometers as shown in Figure 2.
- Connect a precision voltage source to pin 4 (CH0 IN). If the HDA<u>S-8 is used</u>, connect pin 58 (CH0 LOW IN) to analog ground. Ground pin 20 (CLEAR) and momentarily short pin8 (STROBE). Trigger the A/D by connecting pin 7 (EOC) to pin 8 (STROBE). Select proper value for RGAIN and RDELAY by referring to Table 3.
- 3. Adjust the precision voltage source to the value shown in Table 2 for the unipolar zero adjustment (ZERO + 1/2LSB)or the bipolar offset adjustment (-FS + 1/2LSB). Adjust the offset trim potentiometer so that the output code flickers equally between 0000 0000 0000 and 0000 0000 0001.
- 4. Change the output of the precision voltage source to the value shown in Table 2 for the unipolar or bipolar gain adjustment (+FS 1 1/2LSB). Adjust the gain trim potentiometer so that the output flickers equally between 1111 1111 1110 and 1111 1111 1111.

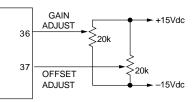


Figure 2. External Adjustment

### **GENERAL OPERATION**

The HDAS devices accept either 16 single-ended or 8 differential input signals. For single-ended circuits, the AMP INLOW (pin 50) input to the instrumentation amplifier must terminate at ANALOG SIGNAL COMMON (pin 41). For differential circuits, both the HIGH and LOW signal inputs must terminate externally for each channel. Tie unused channels to the ANALOG SIGNAL COMMON (pin 41). To obtain additional channels, connect external multiplexers to the AMP IN HIGH (pin 49) and AMP IN LOW (pin 50). Using this scheme, the HDAS-16 can provide 32 single-ended expansion channels while the HDAS-8 can provide



up to 16 differential expansion channels. MPS's MX Series multiplexers are recommended.

The acquisition time is the amount of time the multiplexer, instrumentation amplifier, and sample/hold require to settle within a specified range of accuracy after STROBE (pin 8)goes low. The acquisition time period can be observed by measuring how long EOC is low after the falling edge of STROBE (see Figure 4). For higher gains, increase the acquisition time. Do this by connecting a resistor from RDELAY (pin 6) to +5V (pin 18). An external resistor, RGAIN, can be added to increase the gain value. The gain is equal to 1 without an RGAIN resistor. Table 3 refers to the appropriate RDELAY and RGAIN resistors required for various gains.

The HDAS devices enter the hold mode and are ready for conversion as soon as the one-shot (controling acquisition time) times out. An internal clock is gated ON, and a start-convert pulse is sent to the 12-bit A/D converter,

driving the EOC output high. The HDAS devices can be configured for either bipolar or unipolar operation (see Table 2). The conversion is complete within a maximum of 10 microseconds. The EOC now returns low, the data is valid and sent to the three-state output buffers. The sample/hold amplifier is now ready to acquire new data. The next falling edge of the STROBE pulse repeats the process for the next conversion.

## Multiplexer Addressing

The HDAS devices can be configured in either random orsequential addressing modes. Refer to Table 5 and the subsequent descriptions. The number of channels sequentially addressed can be truncated using the MUX ADDRESS OUT(pins 9, 10, 11 and 12) and appropriate decoding circuitry for highest channel desired. The decoding circuit can drive the CLEAR (pin 20) function low to reset the addressing to channel 0.

INPUT Range ① ②	GAIN	RGAIN (Ω)	RDELAY (Ω) ③	THROUGHPUT ④	SYSTEM ACCURACY (% OF FSR)
±10V	1	OPEN	0 (SHORT)	66.6kHz	±0.009
±5V	2	20.0k	0 (SHORT)	66.6kHz	±0.009
±2.5V	4	6.667k	0 (SHORT)	66.6kHz	±0.009
±1V	10	2.222k	0 (SHORT)	66.6kHz	±0.009
±200mV	50	408.2	7k	40.0kHz	±0.010
±100mV	100	202.0	21k	25.6kHz	±0.011
±50mV	200	100.5	51k	14.5kHz	±0.016

#### Table 3. Input Range Parameters (Typical)

Notes

 $\begin{array}{l} \text{RGAIN} (\Omega) = \underline{20,000} \\ \hline \text{(GAIN} - 1) \end{array}$ 

RDELAY ( $\Omega$ ) = [Total Acquisition Delay (µs) x 1000] - 9000

① The analog input range to the A/D converter is 0 to +10V for unipolar signals and ±10V for bipolar signals.

Table	4.	Output	Cc	oding

UNIPOLAR STRAIGHT BINARY INPUT 0 to +10V LSB 0 to +5V MSB +FS – 1LSB +9.9976 +4.99881111 1111 1111 +1/2FS +5.0000+2.50001000 0000 0000 +1LSB +0.0024 +0.0012 0000 0000 0001 0.0000 7FR0 0.0000 0000 0000 0000 BIPOLAR **OFFSET BINARY\*** INPUT MSB I SR ±10V ±5V +FS – 1LSB 1111 1111 1111 +9.9951+4.9976+1/2FS +5.0000 +2.50001100 0000 0000 +1LSB +0.0049 +0.0024 1000 0000 0001 ZERO 0.0000 0.0000 1000 0000 0000 -FS + 1LSB -9.9951 -4.9976 0000 0000 0001 -FS -10.000 -5.0000 0000 0000 0000

\* For 2's complement coding, add an inverter to the MSB line.

② Full scale can be accommodated for analog signal ranges of ±50mV to ±10V.

3 For gains between 1 and 10, RDELAY (pin 6) must be shorted to +5V (pin 18).

(4) Throughput period equals acquisition and settling delay, plus A/D conversion period (10 microseconds maximum).

#### Table 5. Mux Channel Addressing

		PIN				
		MUX A	DDRESS		ᆸ	
5	13	14	15	16	ON CHANNEL	
MUX Enable	RA8	RA4	RA2	RA1	CH	
0	Х	Х	Х	Х	NONE	
1	0	0	0	0	0	
1	0	0	0	1	1	
1	0	0	1	0	2	HDAS-8
1	0	0	1	1	3	(3-BIT
1	0	1	0	0	4	ADDRESS)
1	0	1	0	1	5	
1	0	1	1	0	6	
1	0	1	1	1	7	
1	1	0	0	0	8	
1	1	0	0	1	9	
1	1	0	1	0	10	
1	1	0	1	1	11	HDAS-16
1	1	1	0	0	12	(4-BIT ADDRESS)
1	1	1	0	1	13	Αυυπεοο)
1	1	1	1	0	14	
1	1	1	1	1	15	



#### **Random Addressing**

Set pin 19 (LOAD) to logic 0. The next falling edge of STROBE will load the MUX CHANNEL ADDRESS present on pin 13 to pin 16. Digital address inputs must be stable 20ns before andafter falling edge of the STROBE pulse.

# Free Running Sequential Addressing

Set pin 19 ( $\overline{\text{LOAD}}$ ) and pin 20 ( $\overline{\text{CLEAR}}$ ) to logic 1 or leave open. Connect pin 7 ( $\overline{\text{EOC}}$ ) to pin 8 ( $\overline{\text{STROBE}}$ ). The fallingedge of  $\overline{\text{EOC}}$  will increment channel address. This means thatwhen the  $\overline{\text{EOC}}$  is low, the digital output data is valid for the previous channel (CHn – 1) rather than the channel indicated on MUX ADDRESS OUTPUT. The HDAS will continually scan all channels.

Example: CH4 has been addressed and a conversion takes place. The  $\overline{\text{EOC}}$  goes low. That channel's (CH4's) data becomes valid, but MUX ADDRESS OUTPUT is now CH5.

#### **Triggered Sequential Addressing**

Set pin 19 ( $\overline{LOAD}$ ) and pin 20 ( $\overline{CLEAR}$ ) to logic 1 or leaveopen. Apply a falling edge trigger pulse to pin 8 ( $\overline{STROBE}$ ). This negative transition causes the contents of the address counter to be incremented by one, followed by an A/D conversion in 9 microseconds.

### **Input Voltage Protection**

As shown in Figure 3, the multiplexer has reversed biased diodes which protect the input channels from being damaged by overvoltage signals. The HDAS input channels areprotected up to 20V beyond the supplies and can be increasedby adding series resistors (Ri) to each channel. The input resistor must limit the current flowing through the protection diodes to 10mA.

The value of Ri for a specific voltage protection range (Vp) can be calculated by the following formula:

Vp = (Rsignal + Ri + Ron) (10mA) where Ron = 2k

NOTE: Increased input series resistance will increase multiplexer settling time significantly.

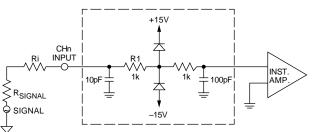


Figure 3. Multiplexer Equivalent Circuit

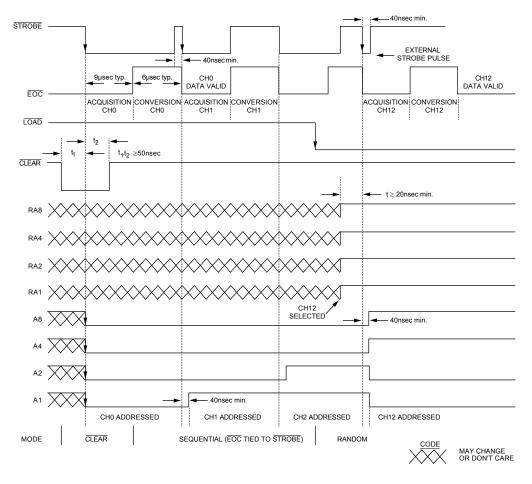
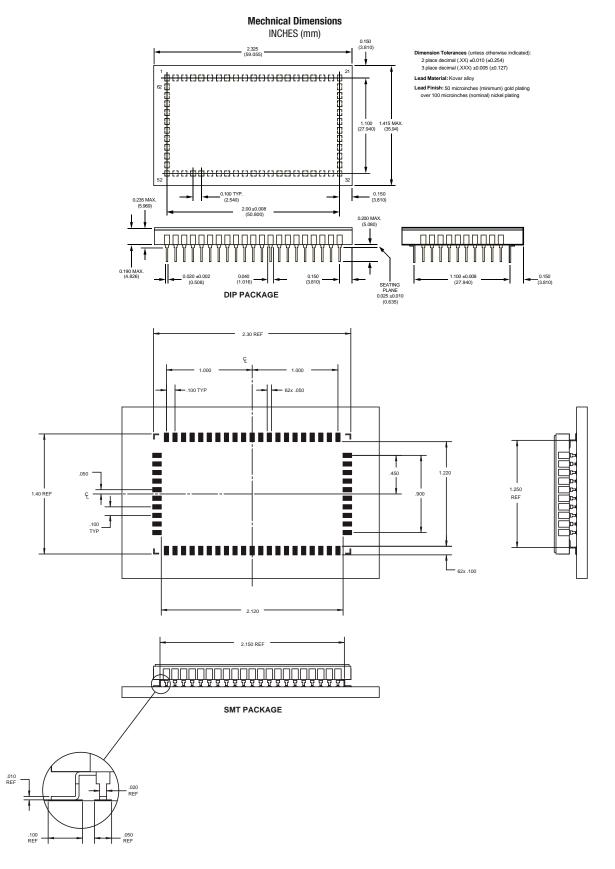


Figure 4. HDAS Timing Diagram



# HDAS-16, HDAS-8

12-Bit, 50kHz, Complete Data Acquisition Systems





	ORDERING INFORM	ATION	
Model Number	Operating Temperature	Package	<b>RoHS Compliant</b>
HDAS-16MC	0 to +70°C	DIP	NO
HDAS-16ME	-40 to +100°C	DIP	NO
HDAS-16MM	-55 to +125°C	DIP	NO
HDAS-16/883	-55 to +125°C	DIP	NO
HDAS-16GC	0 to +70°C	SMT	NO
HDAS-16GE	-40 to +100°C	SMT	NO
HDAS-16GM	-55 to +125°C	SMT	NO
HDAS-16G/883*	-55 to +125°C	SMT	NO
HDAS-16MC-C	0 to +70°C	DIP	YES
HDAS-16ME-C	-40 to +100°C	DIP	YES
HDAS-16MM-C	-55 to +125°C	DIP	YES
HDAS-16MM-QL	-55 to +125°C	DIP	NO
HDAS-16/883-C	-55 to +125°C	DIP	YES
HDAS-16GC-C	0 to +70°C	SMT	YES
HDAS-16GE-C	-40 to +100°C	SMT	YES
HDAS-16GM-C	-55 to +125°C	SMT	YES
HDAS-16G/883-C	-55 to +125°C	SMT	YES

ORDERING INFORMATION			
Model Number	Operating Temperature	Package	<b>RoHS Compliant</b>
HDAS-8MC	0 to +70°C	DIP	NO
HDAS-8ME	-40 to +100°C	DIP	NO
HDAS-8MM	-55 to +125°C	DIP	NO
HDAS-8/883	-55 to +125°C	DIP	NO
HDAS-8GC	0 to +70°C	SMT	NO
HDAS-8GE	-40 to +100°C	SMT	NO
HDAS-8GM	-55 to +125°C	SMT	NO
HDAS-8G/883	-55 to +125°C	SMT	NO
HDAS-8MC-C	0 to +70°C	DIP	YES
HDAS-8ME-C	-40 to +100°C	DIP	YES
HDAS-8MM-C	-55 to +125°C	DIP	YES
HDAS-8MM-QL	-55 to +125°C	DIP	NO
HDAS-8/883-C	-55 to +125°C	DIP	YES
HDAS-8GC-C	0 to +70°C	SMT	YES
HDAS-8GE-C	-40 to +100°C	SMT	YES
HDAS-8GM-C	-55 to +125°C	SMT	YES
HDAS-8G/883-C	-55 to +125°C	SMT	YES

Receptacle for PC board mounting can be ordered through AMP Inc., Part #3-331272-4 (Component Lead Spring Socket), 62 required. The MIL-STD-883 units are available under DESC Drawing Number 5962-8851404.

Contact DATEL for MIL-STD-883 product specifications.

\*HDAS-16G/883 devices are delivered with solder-tin leads.



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